



TEST REPORT SUMMARY

(Short Report)

CLIENT: IPC INTERNATIONAL INC
3000 Lakeside Drive Suite 105N Bannockburn, IL 60015
Attention: Mr. Randy Cherry
Phone: 1-847-597-2806

REFERENCE: IPC-4101E-WAM1/126, IPC-TM-650 2.3.1.1, 2.3.4.2A, 2.4.4B,
2.4.8C, 2.4.8.3A, 2.4.13.1, 2.4.24C, 2.4.24.1, 2.4.24.6, 2.4.25D,
2.4.39, 2.5.1B, 2.5.5.9, 2.5.6B, 2.5.6.2A, 2.5.17.1A, 2.6.2.1A, 2.6.16,
UL94, Customer Technical Requirements

TEST ITEM: Peel Strength, Volume Resistivity, Surface Resistivity, Moisture
Absorption, Dielectric Breakdown, Permittivity and Loss Tangent,
Flexural Strength, Arc Resistance, Thermal Stress, Electric Strength,
Vertical Burning Test, Glass Transition Temperature, Decomposition
Temperature, Z-Axis CTE (TMA), Time to Delamination,
Dimensional Stability, Solderability, Chemical Resistance, Metal
Surface Cleanability, Pressure Cooker Test

SAMPLE: CCL

TEST MATERIAL: EM-371(Z)

SPECIFICATION: IPC-4101E-WAM1/126

TEST RESULTS: The specimens were tested by the indicated test methods within this
report. The actual detailed test results are enclosed.

DATE OF REPORT: 25 June 2025

REPORT No.: 46794E

"INTEGRITY, HONESTY AND KNOWLEDGE"

MICROTEK (CHANGZHOU) PRODUCT SERVICES CO., LTD

NO.19 XINKE ROAD • ELECTRONIC-TECHNOLOGY • CHANGZHOU, JIANGSU, CHINA 213031 •

Tel: 86 519 85487818 • Email: microtek@thetestlab.cn • WWW.THETESTLAB.CN



SUMMARIZED TEST RESULTS:

<u>Test Item</u>	<u>Thin</u>	<u>Thick</u>
Peel Strength	Pass	Pass
Volume Resistivity	Pass	Pass
Surface Resistivity	Pass	Pass
Moisture Absorption	--	Pass
Dielectric Breakdown	--	Pass
Permittivity at 1 MHz, 1 GHz	Pass	Pass
Loss Tangent at 1 MHz, 1 GHz	Pass	Pass
Flexural Strength	--	Pass
Arc Resistance	Pass	Pass
Thermal Stress	Pass	Pass
Electric Strength	Pass	--
Vertical Burning	Pass	Pass
Glass Transition Temperature	--	Pass
Decomposition Temperature	--	Pass
Z-Axis CTE (TMA)	--	Pass
Time to Delamination	--	Pass
Dimensional Stability	Pass	Pass
Solderability	--	Pass
Chemical Resistance	Report Only	Report Only
Metal Surfaces Cleanability	--	Report Only
Pressure Cooker Test	--	Report Only



Peel Strength

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.4.8C Peel Strength of Matallic Clad Laminates

IPC-TM-650 2.4.8.3A Peel Strength of Matallic Clad Laminates at Elevated

RESULTS

Table 1 Peel Strength After Thermal StressThin

Sample Designation	CCL		Sample Identification	EM-371 (Z)
Test Date	2025-06-17		Ambient	24 °C, 55 %RH
Sample No.	Peel Strength (N/mm)			
	Top Crosswise	Top Lengthwise	Bottom Crosswise	Bottom Lengthwise
46794-2-1	1.63			
46794-2-2	1.63			
46794-2-3		1.65		
46794-2-4		1.68		
46794-2-5			1.64	
46794-2-6			1.68	
46794-2-7				1.66
46794-2-8				1.67
Average	1.63	1.67	1.66	1.66
Requirement	≥ 0.80			

**Table 2 Peel Strength After Thermal StressThick**

Sample Designation	CCL		Sample Identification	EM-371 (Z)
Test Date	2025-06-17		Ambient	24 °C, 55 %RH
Sample No.	Peel Strength (N/mm)			
	Top Crosswise	Top Lengthwise	Bottom Crosswise	Bottom Lengthwise
46794-28-1	1.65			
46794-28-2	1.68			
46794-28-3		1.68		
46794-28-4		1.70		
46794-28-5			1.70	
46794-28-6			1.71	
46794-28-7				1.72
46794-28-8				1.74
Average	1.67	1.69	1.71	1.73
Requirement	≥ 1.05			


Table 3 Peel Strength At Elevated Temperature Thin

Sample Designation	CCL		Sample Identification	EM-371 (Z)
Test Date	2025-06-21		Ambient	23 °C, 53 %RH
Sample No.	Peel Strength (N/mm)			
	Top Crosswise	Top Lengthwise	Bottom Crosswise	Bottom Lengthwise
46794-2-9	1.34			
46794-2-10	1.33			
46794-2-11		1.35		
46794-2-12		1.31		
46794-2-13			1.35	
46794-2-14			1.36	
46794-2-15				1.32
46794-2-16				1.33
Average	1.33	1.33	1.36	1.32
Requirement	≥0.70			

**Table 4 Peel Strength At Elevated Temperature Thick**

Sample Designation	CCL		Sample Identification	EM-371 (Z)
Test Date	2025-06-21		Ambient	23 °C, 53 %RH
Sample No.	Peel Strength (N/mm)			
	Top Crosswise	Top Lengthwise	Bottom Crosswise	Bottom Lengthwise
46794-28-9	1.37			
46794-28-10	1.39			
46794-28-11		1.39		
46794-28-12		1.40		
46794-28-13			1.36	
46794-28-14			1.38	
46794-28-15				1.36
46794-28-16				1.37
Average	1.38	1.39	1.37	1.37
Requirement	≥0.70			



Table 5 Peel Strength After Process Solution Thin

Sample Designation	CCL		Sample Identification	EM-371 (Z)
Test Date	2025-06-19		Ambient	24 °C, 55 %RH
Sample No.	Peel Strength (N/mm)			
	Top Crosswise	Top Lengthwise	Bottom Crosswise	Bottom Lengthwise
46794-3-1	1.68			
46794-3-2	1.68			
46794-3-3		1.70		
46794-3-4		1.69		
46794-3-5			1.69	
46794-3-6			1.68	
46794-3-7				1.72
46794-3-8				1.73
Average	1.68	1.69	1.69	1.72
Requirement	≥ 0.55			

**Table 6 Peel Strength After Process Solution Thick**

Sample Designation	CCL		Sample Identification	EM-371 (Z)
Test Date	2025-06-19		Ambient	24 °C, 55 %RH
Sample No.	Peel Strength (N/mm)			
	Top Crosswise	Top Lengthwise	Bottom Crosswise	Bottom Lengthwise
46794-29-1	1.70			
46794-29-2	1.69			
46794-29-3		1.69		
46794-29-4		1.68		
46794-29-5			1.71	
46794-29-6			1.69	
46794-29-7				1.71
46794-29-8				1.75
Average	1.70	1.69	1.70	1.73
Requirement	≥0.80			



Table 7 Peel Strength Low Profile Copper Foil Thin

Sample Designation	CCL		Sample Identification	EM-371 (Z)
Test Date	2025-06-11~2025-06-12		Ambient	23 °C, 54 %RH
Sample No.	Peel Strength (N/mm)			
	Top Crosswise	Top Lengthwise	Bottom Crosswise	Bottom Lengthwise
46794-49-1	1.32			
46794-49-2	1.32			
46794-49-3		1.27		
46794-49-4		1.28		
46794-49-5			1.24	
46794-49-6			1.24	
46794-49-7				1.26
46794-49-8				1.27
Average	1.32	1.28	1.24	1.26


Table 8 Peel Strength Low Profile Copper Foil Thick

Sample Designation	CCL		Sample Identification	EM-371 (Z)
Test Date	2025-06-11~2025-06-12		Ambient	23 °C, 54 %RH
Sample No.	Peel Strength (N/mm)			
	Top Crosswise	Top Lengthwise	Bottom Crosswise	Bottom Lengthwise
46794-52-1	1.28			
46794-52-2	1.28			
46794-52-3		1.29		
46794-52-4		1.29		
46794-52-5			1.33	
46794-52-6			1.31	
46794-52-7				1.30
46794-52-8				1.31
Average	1.28	1.29	1.32	1.31



Volume and Surface Resistivity

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.5.17.1A Volume and Surface Resistivity of Dielectric Materials

RESULTS

Table 9 Volume and Surface resistivity Humidity Conditioning Thin

Sample Designation	CCL		Sample Identification	EM-371(Z)	
Test Date	2025-06-19~2025-06-23		Ambient	23 °C, 48% RH	
Sample No.	Average Thickness T	Surface Resistance R'	Surface Resistivity $r=R'P/D_4$	Volume Resistance R	Volume Resistivity $r=RA/T$
	(cm)	(MΩ)	(MΩ)	(MΩ)	(MΩ·cm)
46794-8-1	0.0391	2.9E+04	9.1E+06	2.4E+04	3.1E+06
46794-8-2	0.0390	4.6E+04	1.4E+07	3.7E+04	4.9E+06
46794-8-3	0.0393	3.4E+04	1.1E+07	3.8E+04	5.0E+06
Average		/	1.1E+07	/	4.3E+06
Requirement		/	$\geq 10^4$	/	$\geq 10^6$

Table 10 Volume and Surface Resistivity at Elevated Temperature Humidity Thin

Sample Designation	CCL		Sample Identification	EM-371(Z)	
Test Date	2025-06-23~2025-06-24		Ambient	25 °C, 53% RH	
Sample No.	Average Thickness T	Surface Resistance R'	Surface Resistivity $r=R'P/D_4$	Volume Resistance R	Volume Resistivity $r=RA/T$
	(cm)	(MΩ)	(MΩ)	(MΩ)	(MΩ·cm)
46794-9-1	0.0393	7.9E+05	2.5E+08	5.6E+05	7.4E+07
46794-9-2	0.0392	8.7E+05	2.8E+08	6.1E+05	8.0E+07
46794-9-3	0.0395	6.9E+05	2.2E+08	6.0E+05	7.9E+07
Average		/	2.5E+08	/	7.8E+07
Requirement		/	$\geq 10^3$	/	$\geq 10^3$



Table 11 Volume and Surface Resistivity Humidity Conditioning Thick

Sample Designation	CCL		Sample Identification	EM-371(Z)	
Test Date	2025-06-11~2025-06-18		Ambient	22 °C, 50% RH	
Sample No.	Average Thickness T	Surface Resistance R'	Surface Resistivity $r=R'P/D_4$	Volume Resistance R	Volume Resistivity $r=RA/T$
	(cm)	(MΩ)	(MΩ)	(MΩ)	(MΩ·cm)
46794-35-1	0.0980	1.2E+05	3.4E+06	3.2E+05	8.4E+07
46794-35-2	0.0977	1.3E+05	3.7E+06	4.0E+05	1.1E+08
46794-35-3	0.0978	9.6E+04	2.7E+06	2.9E+05	7.6E+07
Average		/	3.3E+06	/	8.8E+07
Requirement		/	$\geq 10^4$	/	$\geq 10^4$

Table 12 Volume and Surface Resistivity at Elevated Temperature Humidity Thick

Sample Designation	CCL		Sample Identification	EM-371(Z)	
Test Date	2025-06-23~2025-06-24		Ambient	25 °C, 53% RH	
Sample No.	Average Thickness T	Surface Resistance R'	Surface Resistivity $r=RP/D_4$	Volume Resistance R	Volume Resistivity $r=RA/T$
	(cm)	(MΩ)	(MΩ)	(MΩ)	(MΩ·cm)
46794-36-1	0.0975	1.6E+06	4.5E+07	5.3E+05	1.4E+08
46794-36-2	0.0970	1.9E+06	5.4E+07	6.3E+05	1.7E+08
46794-36-3	0.0973	2.2E+06	6.1E+07	5.1E+05	1.3E+08
Average		/	5.3E+07	/	1.5E+08
Requirement		/	$\geq 10^3$	/	$\geq 10^3$



Moisture Absorption

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.6.2.1A Water Absorption, Metal Clad Plastic Laminates

RESULTS

Table 13 Moisture Absorption

Sample Designation	CCL		Sample Identification	EM-371(Z)
Test Date	2025-06-10~2025-06-18		Ambient	25 °C, (51~64)% RH
Sample No.	mass(g)		increasing weight percent of mass(%)	
	m ₁	m ₂		
46794-26-10	4.9711	4.9783		0.14
46794-26-11	5.0037	5.0106		0.14
46794-26-12	4.9996	5.0069		0.15
Average				0.14
Requirement				≤0.5



Dielectric Breakdown

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.5.6B Dielectric Breakdown of Rigid Printed Wiring Material

RESULTS

Table 14 Dielectric Breakdown

Sample Designation		CCL	Sample Identification	EM-371(Z)
Test Date		2025-06-10~2025-06-12	Ambient	22 °C, 52% RH
Sample No.		Thickness (mm)	Voltage (kV)	Minimum Voltage (kV)
46794-38-1	Machine direction	0.966	46.0+N.B	46+N.B
46794-38-2		0.965	46.1+N.B	
46794-38-3	Transverse direction	0.967	46.6+N.B	
46794-38-4		0.967	46.0+N.B	
Requirement				≥40



Permittivity and Loss Tangent

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.5.5.9 Permittivity and Loss Tangent, Parallel Plate, 1MHz to 1.5GHz

RESULTS

Table 15 Permittivity and Loss Tangent

Sample Designation	CCL		Sample Identification	EM-371(Z)
Test Date	2025-06-10~2025-06-13		Ambient	22 °C, 66% RH
Sample No.	Test Frequency	Sample Thickness (mm)	Permittivity	Loss Tangent
46794-1-1	1 MHz	0.397	4.9	0.011
46794-1-2		0.395	5.0	0.011
46794-1-3		0.398	4.9	0.010
Average		0.397	4.9	0.011
Requirement			≤5.4	≤0.035
46794-26-1	1 MHz	0.969	5.1	0.008
46794-26-2		0.970	5.1	0.009
46794-26-3		0.959	5.1	0.009
Average		0.966	5.1	0.009
Requirement			≤5.4	≤0.035
46794-1-4	1 GHz	0.394	4.7	0.013
46794-1-5		0.396	4.7	0.014
46794-1-6		0.396	4.7	0.013
Average		0.395	4.7	0.013
Requirement			≤5.2	≤0.035
46794-26-4	1 GHz	0.972	4.8	0.011
46794-26-5		0.970	4.9	0.012
46794-26-6		0.975	4.8	0.011
Average		0.972	4.8	0.011
Requirement			≤5.2	≤0.035



Flexural Strength

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.4.4B Flexural Strength of Laminates (at Ambient Temperature)

RESULTS

Table 16 Flexural Strength Test

Sample Designation	CCL		Sample Identification		EM-371 (Z)		
Test Date	2025-06-11		Ambient		23 °C, 54 %RH		
Sample No.	Span	Load	Width	Thickness	Flexural Strength S	Average	Requirement
	L	P	b	d			
	(mm)	(N)	(mm)	(mm)			
46794-31-1 (Length Direction)	25.40	288.474	25.62	0.967	459	457	≥415
46794-31-2 (Length Direction)		286.974	25.60	0.969	455		
46794-31-3 (Cross Direction)		368.416	25.57	0.972	581	582	≥345
46794-31-4 (Cross Direction)		367.858	25.52	0.970	584		



Arc Resistance

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.5.1B Arc Resistance of Printed Wiring Material

RESULTS

Table 17 Arc Resistance

Sample Designation		CCL	Sample Identification	EM-371(Z)	
Test Date		2025-06-10~2025-06-12	Ambient	23 °C, 49% RH	
Sample No.		Thickness	Times	Average	Requirement
		(mm)	(s)	(s)	(s)
46794-10-1	Thin	0.394	171	177	≥60
46794-10-2		0.394	180		
46794-10-3		0.396	181		
46794-38-6	Thick	0.963	181	181	
46794-38-7		0.966	181		
46794-38-8		0.964	181		



Thermal Stress

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.4.13.1 Thermal Stress of Laminates

RESULTS

Table 18 Thermal Stress

Sample Designation	CCL		Sample Identification	EM-371(Z)
Test Date	2025-06-10		Ambient	25 °C, 53%RH
Sample No.			Test result	
46794-12-1	Etched	Top	Thin	No evidence of blistering, delamination, wrinkling and cracking
46794-12-2				No evidence of blistering, delamination, wrinkling and cracking
46794-12-3				No evidence of blistering, delamination, wrinkling and cracking
46794-12-4		Bottom		No evidence of blistering, delamination, wrinkling and cracking
46794-12-5				No evidence of blistering, delamination, wrinkling and cracking
46794-12-6				No evidence of blistering, delamination, wrinkling and cracking
46794-15-1	Unetched	Top		No evidence of blistering, delamination, wrinkling and cracking
46794-15-2				No evidence of blistering, delamination, wrinkling and cracking
46794-15-3				No evidence of blistering, delamination, wrinkling and cracking
46794-15-4		Bottom		No evidence of blistering, delamination, wrinkling and cracking
46794-15-5				No evidence of blistering, delamination, wrinkling and cracking
46794-15-6				No evidence of blistering, delamination, wrinkling and cracking
46794-40-1	Etched	Top	Thick	No evidence of blistering, delamination, wrinkling and cracking
46794-40-2				No evidence of blistering, delamination, wrinkling and cracking
46794-40-3				No evidence of blistering, delamination, wrinkling and cracking
46794-40-4		Bottom		No evidence of blistering, delamination, wrinkling and cracking
46794-40-5				No evidence of blistering, delamination, wrinkling and cracking
46794-40-6				No evidence of blistering, delamination, wrinkling and cracking
46794-44-1	Unetched	Top		No evidence of blistering, delamination, wrinkling and cracking
46794-44-2				No evidence of blistering, delamination, wrinkling and cracking
46794-44-3				No evidence of blistering, delamination, wrinkling and cracking
46794-44-4		Bottom		No evidence of blistering, delamination, wrinkling and cracking
46794-44-5				No evidence of blistering, delamination, wrinkling and cracking
46794-44-6				No evidence of blistering, delamination, wrinkling and cracking



Electric Strength

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.5.6.2A Electric Strength of Printed Wiring Material

RESULTS

Table 19 Electric Strength

Sample Designation	CCL	Sample Identification	EM-371(Z)
Test Date	2025-06-10~2025-06-12	Ambient	22 °C, 52% RH
Sample No.	Average Thickness (mm)	Voltage (kV)	Electric Strength (kV/mm)
46794-12-7	0.394	14.78	37.51
46794-12-8	0.395	15.00	37.97
46794-12-9	0.392	14.74	37.60
Average			38
Requirement			≥30



Vertical Burning Test

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

UL94 STANDARD FOR SAFETY Tests for Flammability of Plastic Materials for Parts in Devices and Appliances Section 8 50W (20 mm) Vertical Burning Test; V-0, V-1, or V-2

RESULTS

Table 20 Vertical Burning Test Thin

Sample Designation		CCL			Sample Identification		EM-371(Z)		
Test Date		2025-06-10~2025-06-17			Ambient		22 °C, 51% RH		
Pre-conditioning	Sample No.	Sample Thk (mm)	Afterflames (s)		Afterglow (s)	Sum of after flames (s)	Sum of afterflame and afterglow (s)	Did samples burn to the clamp?	Did the cotton ignite?
			(t ₁)	(t ₂)	(t ₃)	(t ₁ + t ₂)	(t ₂ + t ₃)		
Condition A: 48 Hours (23±2) °C (50±10)% RH	46794-11-1	0.391	1	0	0	1	0	No	No
	46794-11-2	0.390	1	0	0	1	0	No	No
	46794-11-3	0.389	0	0	0	0	0	No	No
	46794-11-4	0.391	0	0	0	0	0	No	No
	46794-11-5	0.391	0	0	0	0	0	No	No
	Avg:	0.390	Max: 1			Sum: 2	Max: 0	Pass	Pass
Condition B: 24 Hours (125±2) °C	46794-11-6	0.389	0	0	0	0	0	No	No
	46794-11-7	0.390	0	0	0	0	0	No	No
	46794-11-8	0.391	0	0	0	0	0	No	No
	46794-11-9	0.391	0	0	0	0	0	No	No
	46794-11-10	0.390	0	0	0	0	0	No	No
	Avg:	0.390	Max: 0			Sum: 0	Max: 0	Pass	Pass
Results	V-0								
Requirement	V-0								



Table 21 Vertical Burning Test Thick

Sample Designation		CCL			Sample Identification		EM-371(Z)		
Test Date		2025-06-10~2025-06-17			Ambient		22 °C, 51% RH		
Pre-conditioning	Sample No.	Sample Thk (mm)	Afterflames (s)		Afterglow (s)	Sum of after flames (s)	Sum of afterflame and afterglow (s)	Did samples burn to the clamp?	Did the cotton ignite?
			(t ₁)	(t ₂)					
Condition A: 48 Hours (23±2) °C (50±10)% RH	46794-37-1	0.965	0	0	0	0	0	No	No
	46794-37-2	0.963	1	0	0	1	0	No	No
	46794-37-3	0.968	0	0	0	0	0	No	No
	46794-37-4	0.969	0	0	0	0	0	No	No
	46794-37-5	0.968	0	0	0	0	0	No	No
	Avg:	0.967	Max: 1			Sum: 1	Max: 0	Pass	Pass
Condition B: 24 Hours (125±2) °C	46794-37-6	0.971	1	0	0	1	0	No	No
	46794-37-7	0.969	3	0	0	3	0	No	No
	46794-37-8	0.968	1	0	0	1	0	No	No
	46794-37-9	0.966	0	3	0	3	3	No	No
	46794-37-10	0.966	0	0	0	0	0	No	No
	Avg:	0.968	Max: 3			Sum: 8	Max: 3	Pass	Pass
Results		V-0							
Requirement		V-0							



Glass Transition Temperature

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.4.25D Glass Transition Temperature and Cure Factor by DSC

RESULTS

Table 22 Glass Transition Temperature

Sample Designation	CCL	Sample Identification	EM-371(Z)
Test Date	2025-06-13~2025-06-16	Ambient	25 °C, 66% RH
Sample Number	46794-27-1		
Element	Measurement (°C)		Requirement
Tg1	188.56		≥170
Tg2	194.45		/
Cure Factor ΔTg	5.89		/



Decomposition Temperature

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.4.24.6 Decomposition Temperature (Td) of Laminate Material Using TGA

RESULTS

Table 23 Decomposition Temperature

Sample Designation	CCL	Sample Identification	EM-371(Z)
Test Date	2025-06-17~2025-06-19	Ambient	25 °C, 58% RH
Sample Number	Decomposition temperature (°C)		
	mass loss at 5%		
46794-26-7	360.56		
Requirement	≥340		



Z-Axis CTE (TMA)

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.4.24C Glass Transition Temperature and Z-Axis Thermal Expansion by TMA

RESULTS

Table 24 Z-Axis CTE (TMA)

Sample Designation	CCL		Sample Identification	EM-371(Z)	
Test Date	2025-06-15~2025-06-16		Ambient	25 °C, 66% RH	
Sample Number	Z-CTE($\mu\text{m}/\text{m}\cdot^{\circ}\text{C}$)			PTE (%)	Tg($^{\circ}\text{C}$)
	(50~100) $^{\circ}\text{C}$	(220~260) $^{\circ}\text{C}$	(50~260) $^{\circ}\text{C}$	(50~260) $^{\circ}\text{C}$	
46794-26-8	34.70	176.1	84.95	1.78	184.44
46794-26-9	33.08	166.5	81.30	1.71	184.47
Requirement	≤ 60	≤ 300	/	≤ 3.0	≥ 170



Time to Delamination

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.4.24.1 Time to Delamination (TMA Method)

RESULTS

Table 25 Time to Delamination

Sample Designation	CCL	Sample Identification	EM-371(E)	
Test Date	2025-06-14~2025-06-15	Ambient	25 °C, 64% RH	
Sample No.	Test Item	Time of Reversible Event (min)	Time of Delaminate (min)	Requirement (min)
46794-27-2	T260	/	>30	≥30
46794-27-3		/	>30	
46794-27-4	T288	/	>15	≥15
46794-27-5		/	>15	
46794-27-6	T300	/	>2	≥2
46794-27-7		/	>2	



Dimensional Stability

REFERENCES

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.4.39A Dimensional Stability, Glass Reinforced Thin Laminates

RESULTS

Table 26 Dimensional Stability Thin

Sample Designation	CCL		Sample Identification		EM-371 (Z)			
Test Date	2025-05-30~2025-06-18		Ambient		24 °C, (51~53)% RH			
Sample No.	After Bake Process (ppm)				After Thermal Stress Process (ppm)			
	MD		TD		MD		TD	
46794-5	153	270	208	114	81	246	185	91
46794-6	185	220	134	118	129	159	79	36
46794-7	149	173	138	205	105	173	122	138
Average	192		153		149		108	
Requirement	-300~300							

Table 27 Dimensional Stability Thick

Sample Designation	CCL		Sample Identification		EM-371 (Z)			
Test Date	2025-05-30~2025-06-18		Ambient		24 °C, (51~53)% RH			
Sample No.	After Bake Process (ppm)				After Thermal Stress Process (ppm)			
	MD		TD		MD		TD	
46794-32	157	177	161	138	173	76	63	59
46794-33	133	129	153	189	121	76	35	63
46794-34	197	149	169	213	165	113	75	99
Average	157		171		121		66	
Requirement	-300~300							



Solderability

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC J-STD-003C Solderability Tests for Printed Boards Section 4.2.1 Edge Dip Test

RESULTS

Table 28 Solderability Thin

Sample Designation	/	Sample Identification	/
Test Date	/	Ambient	/
Sample No.	Test result		
No Requirement			

Table 29 Solderability Thick

Sample Designation	CCL	Sample Identification	EM-371(Z)
Test Date	2025-06-04	Ambient	25 °C, 51% RH
Sample No.	Test result		
46794-43-1	Sample surface exhibits good wetting		
46794-43-2	Sample surface exhibits good wetting		
46794-43-3	Sample surface exhibits good wetting		



Chemical Resistance

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.3.4.2A Chemical Resistance of Laminates, Prepreg, and Coated Foil Products, by Solvent Exposure

RESULTS

Table 30 Chemical Resistance

Sample Designation	CCL			Sample Identification	EM-371(Z)	
Test Date	2025-06-23			Ambient	25 °C, 52% RH	
Sample No.	Thickness (mm)	Weight (mg)		Increase Weight (mg)	Appearance Inspection	
		W ₁	W ₂		W ₂ -W ₁	After Bake
46794-1-7	0.392	1992.8	1998.6	5.8	no any change	no any change
46794-1-8	0.390	1983.1	1992.1	9.0	no any change	no any change
46794-1-9	0.395	1997.2	2005.8	8.6	no any change	no any change
Average				7.8	/	
46794-26-10	0.963	4968.2	4980.9	12.7	no any change	no any change
46794-26-11	0.959	5000.6	5013.5	12.9	no any change	no any change
46794-26-12	0.962	4996.6	5008.2	11.6	no any change	no any change
Average				12.4	/	



Metal Surface Cleanability

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.3.1.1 Chemical Cleaning of Metal-Clad Laminate

RESULTS

Table 31 Metal Surface Cleanability

Sample Designation	CCL	Sample Identification	EM-371(Z)
Test Date	2025-06-23~2025-06-24	Ambient	20 °C, 50% RH
Sample Number	Test Result		
46794-27-1	The metal cladding on the test specimen shall be cleaned to a uniform matte finish. Deionized or distilled water poured on the metal surface does not bead or form puddles.		
46794-27-2	The metal cladding on the test specimen shall be cleaned to a uniform matte finish. Deionized or distilled water poured on the metal surface does not bead or form puddles.		
46794-27-3	The metal cladding on the test specimen shall be cleaned to a uniform matte finish. Deionized or distilled water poured on the metal surface does not bead or form puddles.		
Requirements	The metal cladding on the test specimen shall be cleaned to a uniform matte finish. Deionized or distilled water poured on the metal surface does not bead or form puddles.		



Pressure Cooker Test

REFERENCE

Customer Technical Requirement

IPC-4101E-WAM1 Specification for Base Materials for Rigid and Multilayer Printed Boards

IPC-TM-650 2.6.16 Pressure Vessel Method for Glass Epoxy Laminate Integrity

RESULTS

Table 32 Pressure Cooker Test

Sample Designation	CCL	Sample Identification	EM-371(Z)
Test Date	2025-06-23	Ambient	23 °C, 52% RH
Sample No.	Test result		
46794-39-1	Grade 5: The sample have no measles, blisters, or surface erosion.		
46794-39-2	Grade 5: The sample have no measles, blisters, or surface erosion.		
46794-39-3	Grade 5: The sample have no measles, blisters, or surface erosion.		
46794-39-4	Grade 5: The sample have no measles, blisters, or surface erosion.		
46794-39-5	Grade 5: The sample have no measles, blisters, or surface erosion.		

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Edited by:

Liu Dengping

Liu Dengping

Date: 2025-06-25

Reviewed by:

Celina Gu

Celina Gu

Date: 2025-06-26

Approved by:

Jesse Yan

Jesse Yan

Date: 2025-06-26